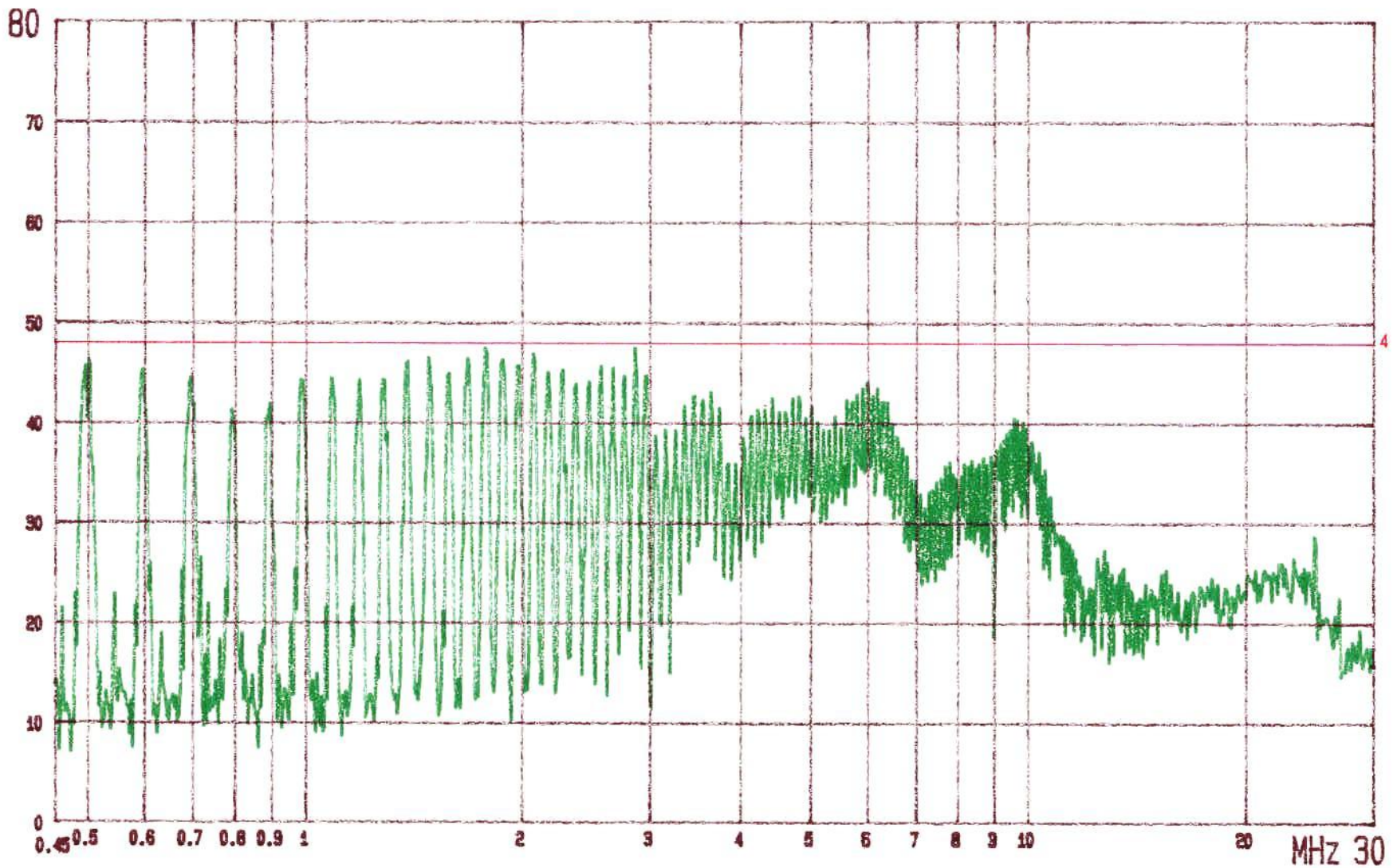


Appendix 1 : Plotted Data of Power Line Conducted Emissions

dBuV



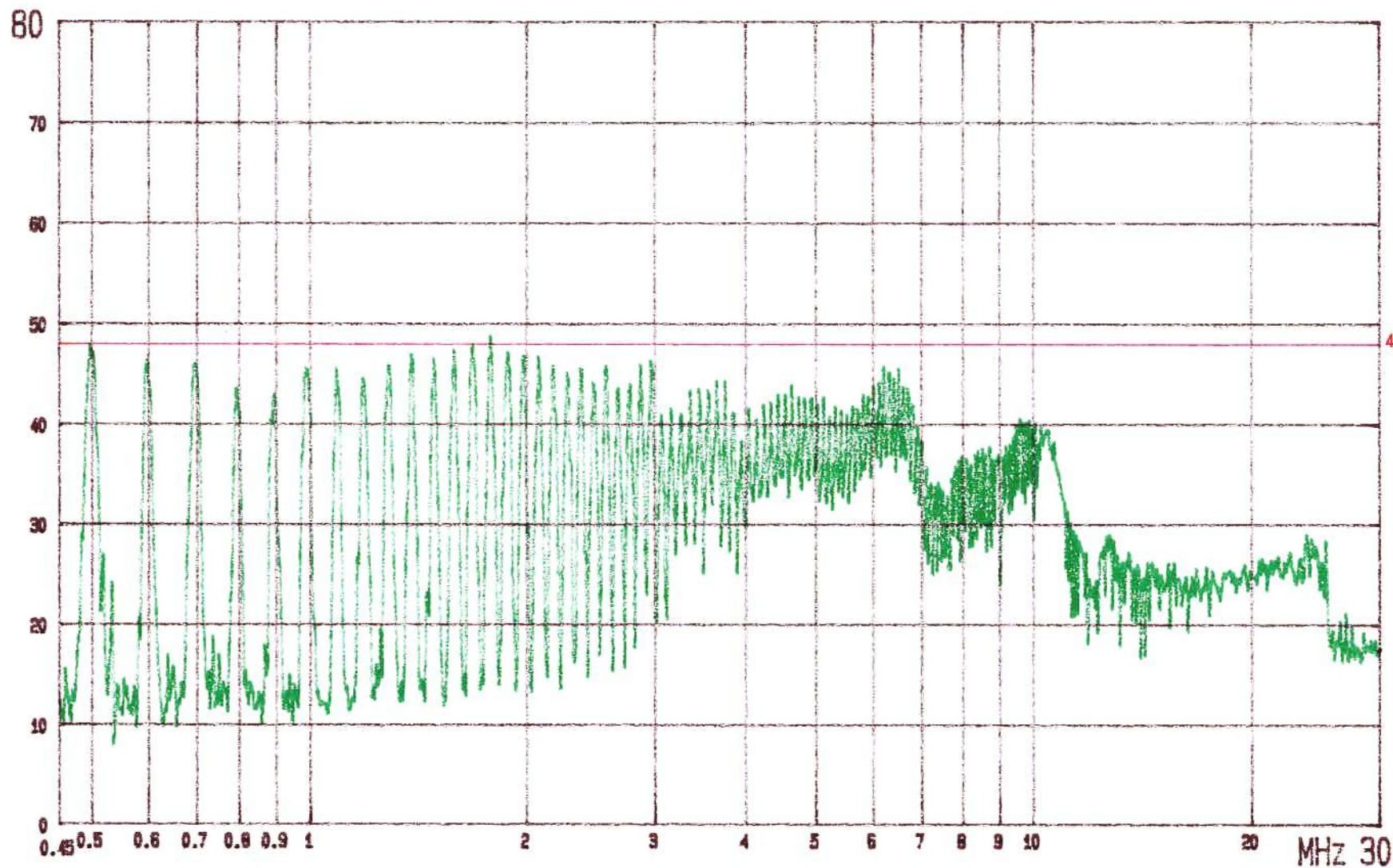
CONDUSTED TEST
MODEL: SS0001

EUT: USB DONGLE
MODE: CH LO (POWER HI)

4: QP
LISN: N

CLASS B LIMIT
ETC EMI LAB.

dBuV



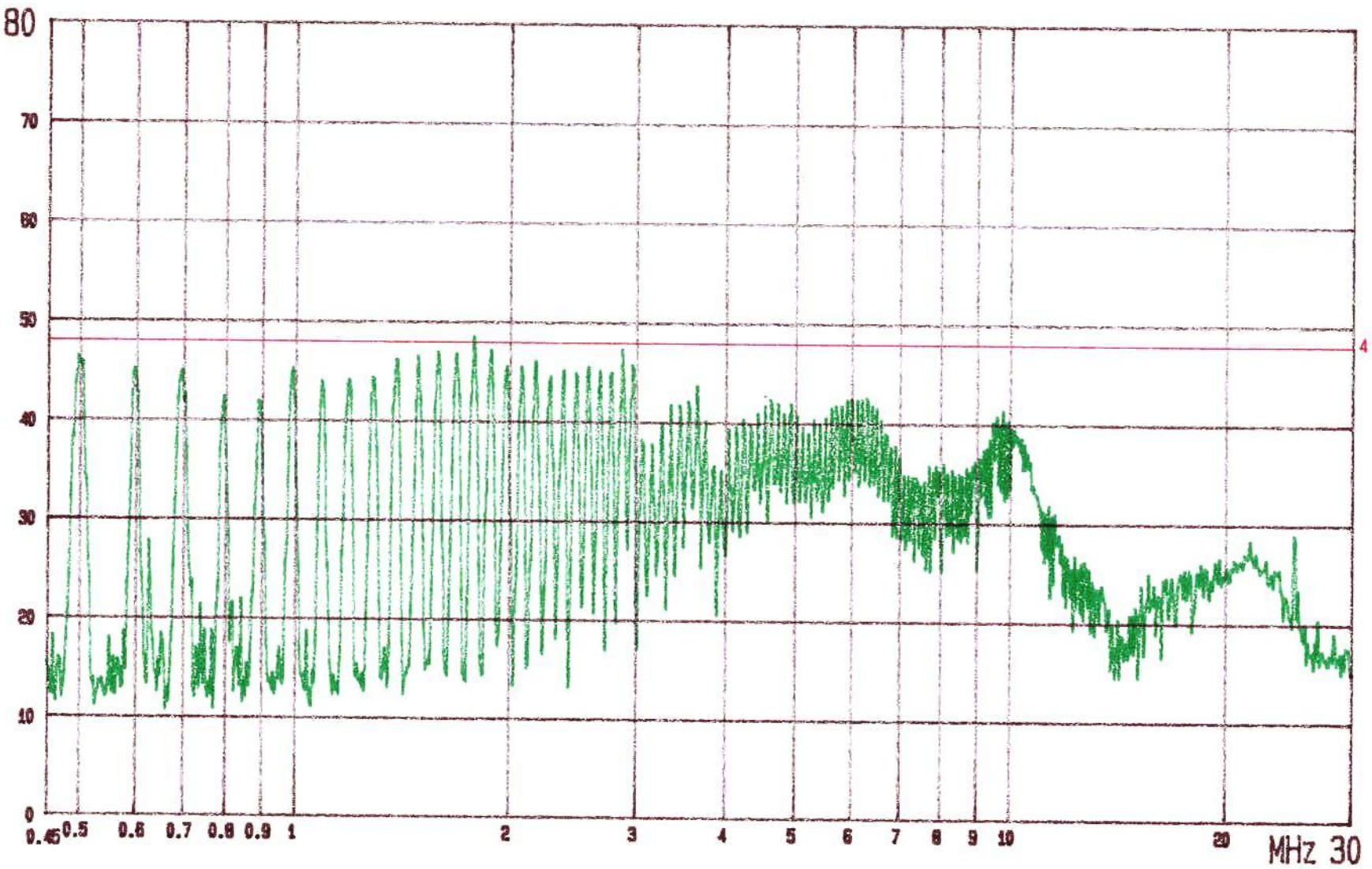
CONDUSTED TEST
MODEL: SS0001

EUT: USB DONGLE
MODE: CH HI (POWER HI)

4: QP
LISN: N

CLASS B LIMIT
ETC EMI LAB.

dBuV



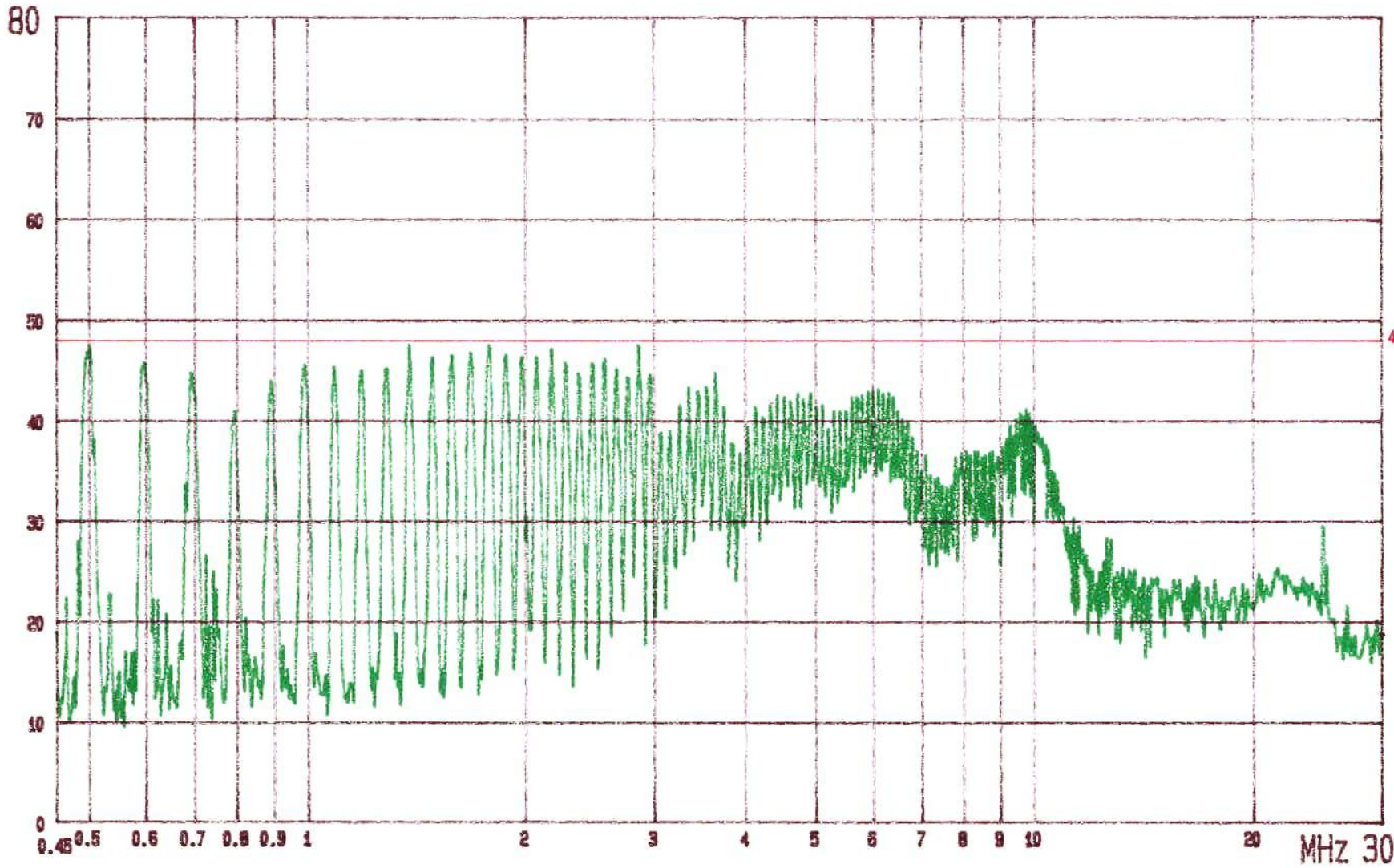
CONDUSTED TEST
MODEL: SS0001

EUT: USB DONGLE
MODE: CH MI (POWER HI)

4: GP
LISN: L1

CLASS B LIMIT
ETC EMI LAB.

dBuV



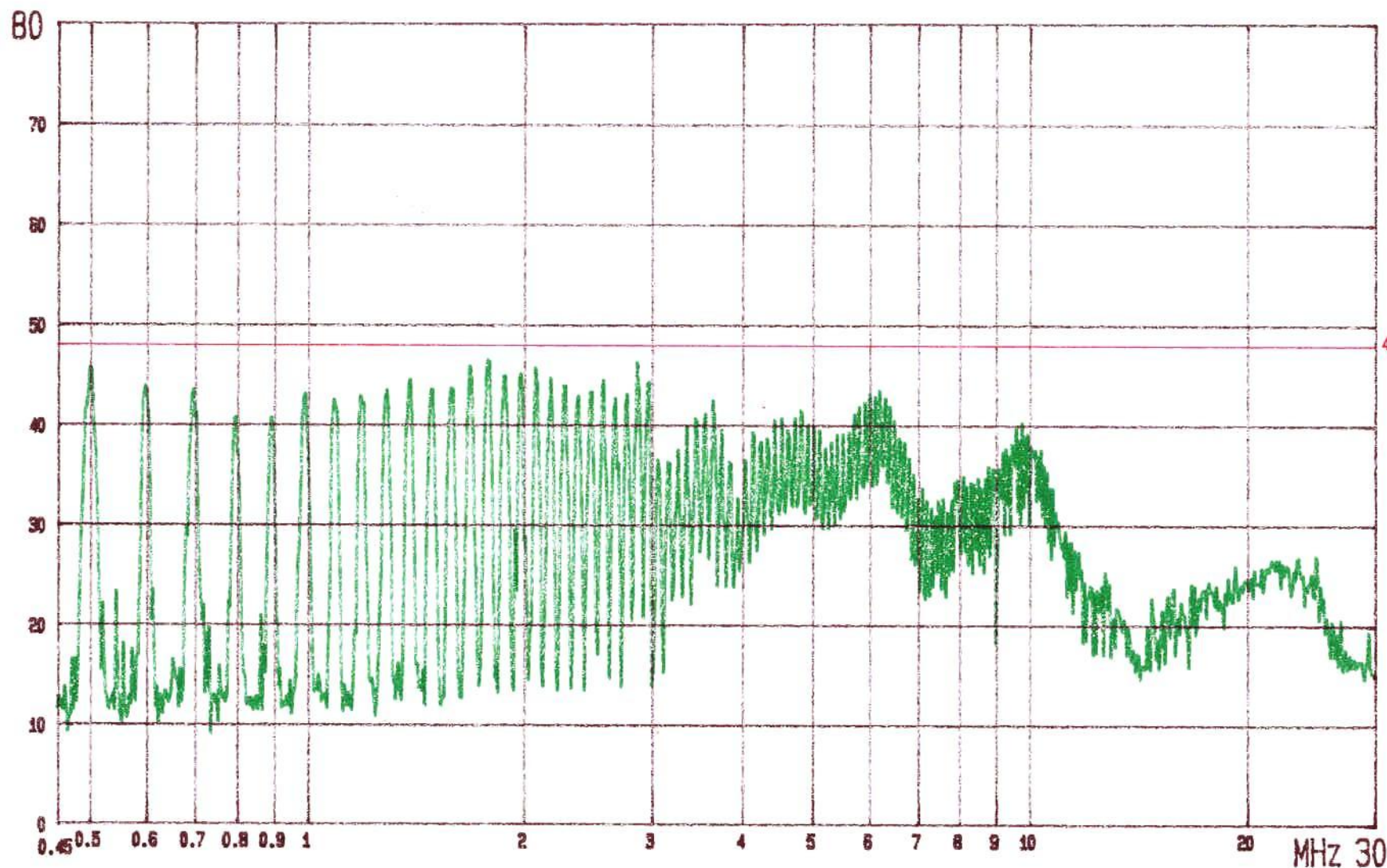
CONDUSTED TEST
MODEL: SS0001

EUT: USB DONGLE
MODE: CH MI (POWER HI)

4: QP
LISN: N

CLASS B LIMIT
ETC EMI LAB.

dBuV



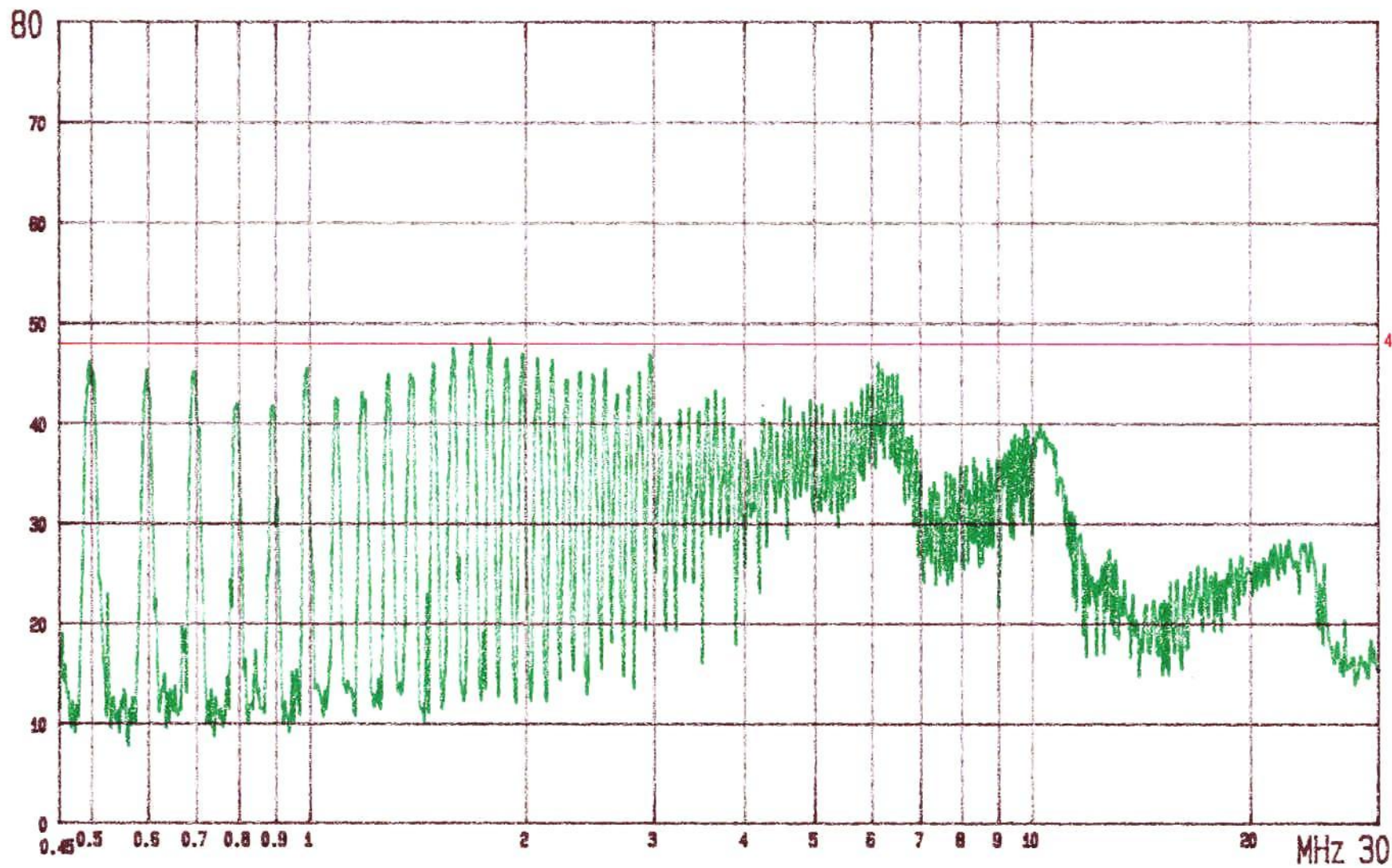
CONDUSTED TEST
MODEL:SS0001

EUT: USB DONGLE
MODE: CH LO (POWER HI)

4: GP
LISN: L1

CLASS B LIMIT
ETC EMI LAB.

dBuV



CONDUSTED TEST
MODEL: SS0001

EUT: USB DONGLE
MODE: CH HI (POWER HI)

4: QP
LISN: L1

CLASS B LIMIT
ETC EMI LAB.

Appendix 2 : Plotted Data for Separation of Adjacent Channel

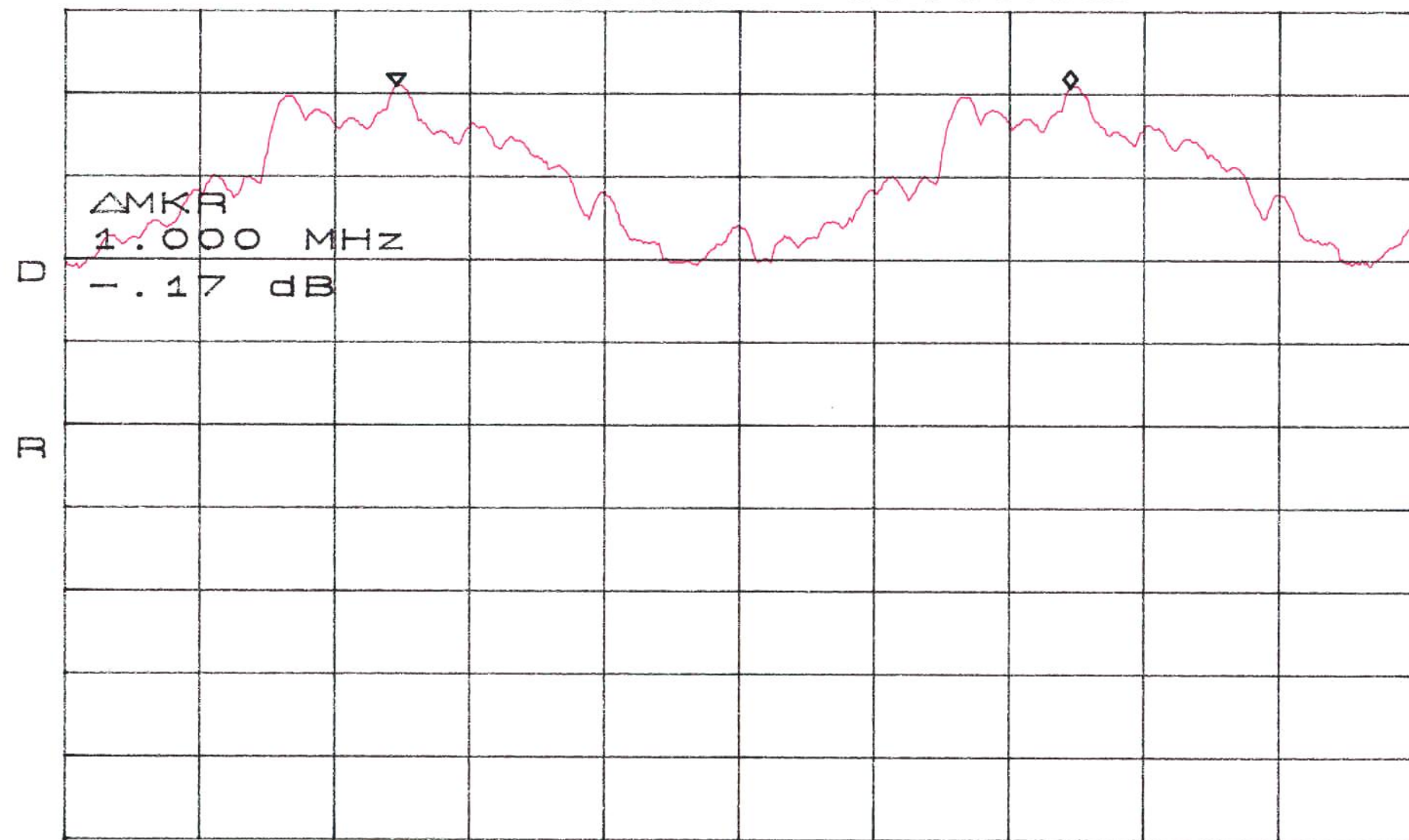
ATTEN 10dB

RL 21.0dBm

10dB/

$\Delta MKR - .17dB$

1.0000MHz



CENTER 2.402500GHz

SPAN 2.000MHz

*RBW 30kHz

*VBW 100kHz

*SWP 500ms

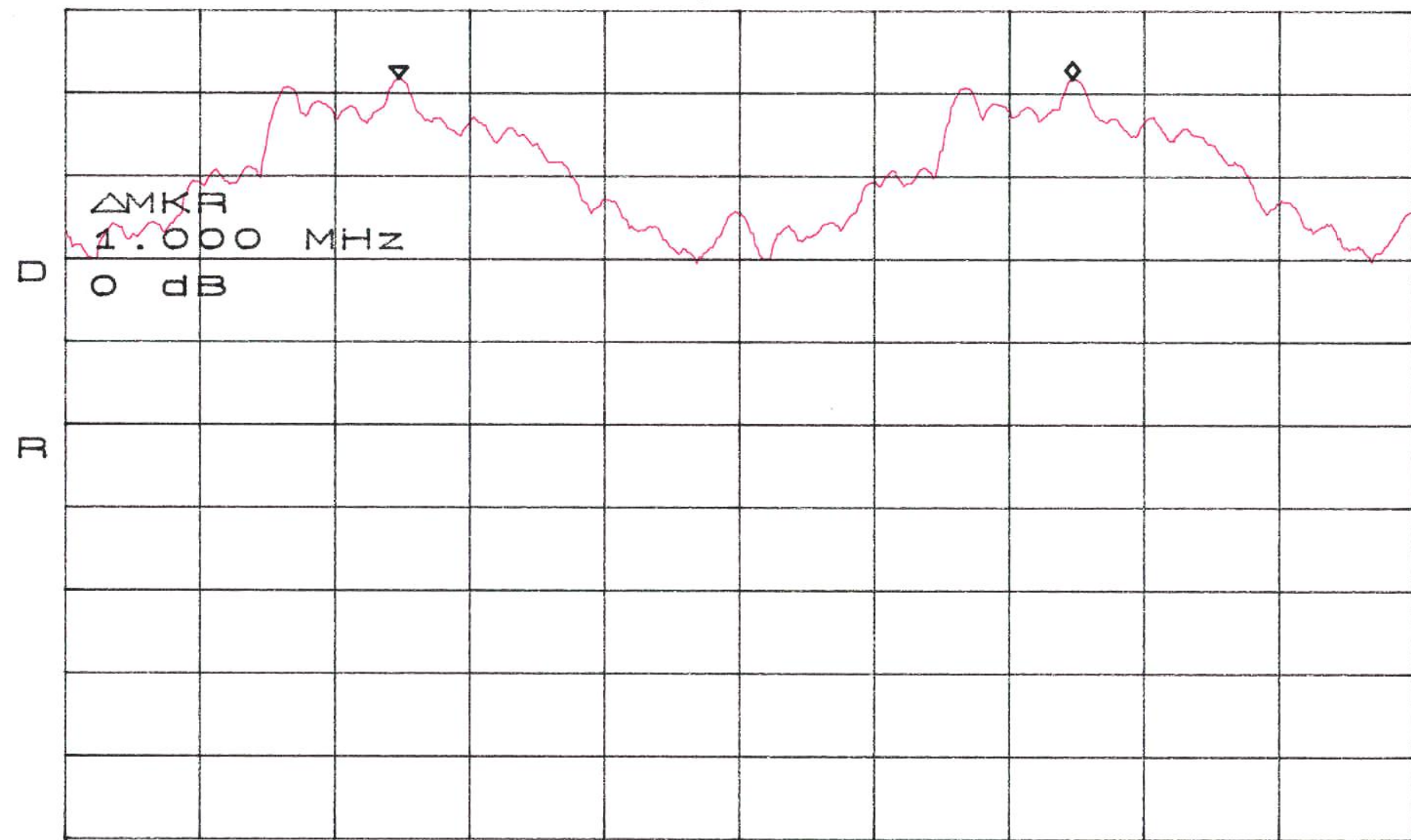
ATTEN 10dB

RL 21.0dBm

10dB/

ΔMKR 0dB

1.000MHz



CENTER 2.441500GHz

SPAN 2.000MHz

*RBW 30KHz

*VBW 100KHz

*SWP 500ms

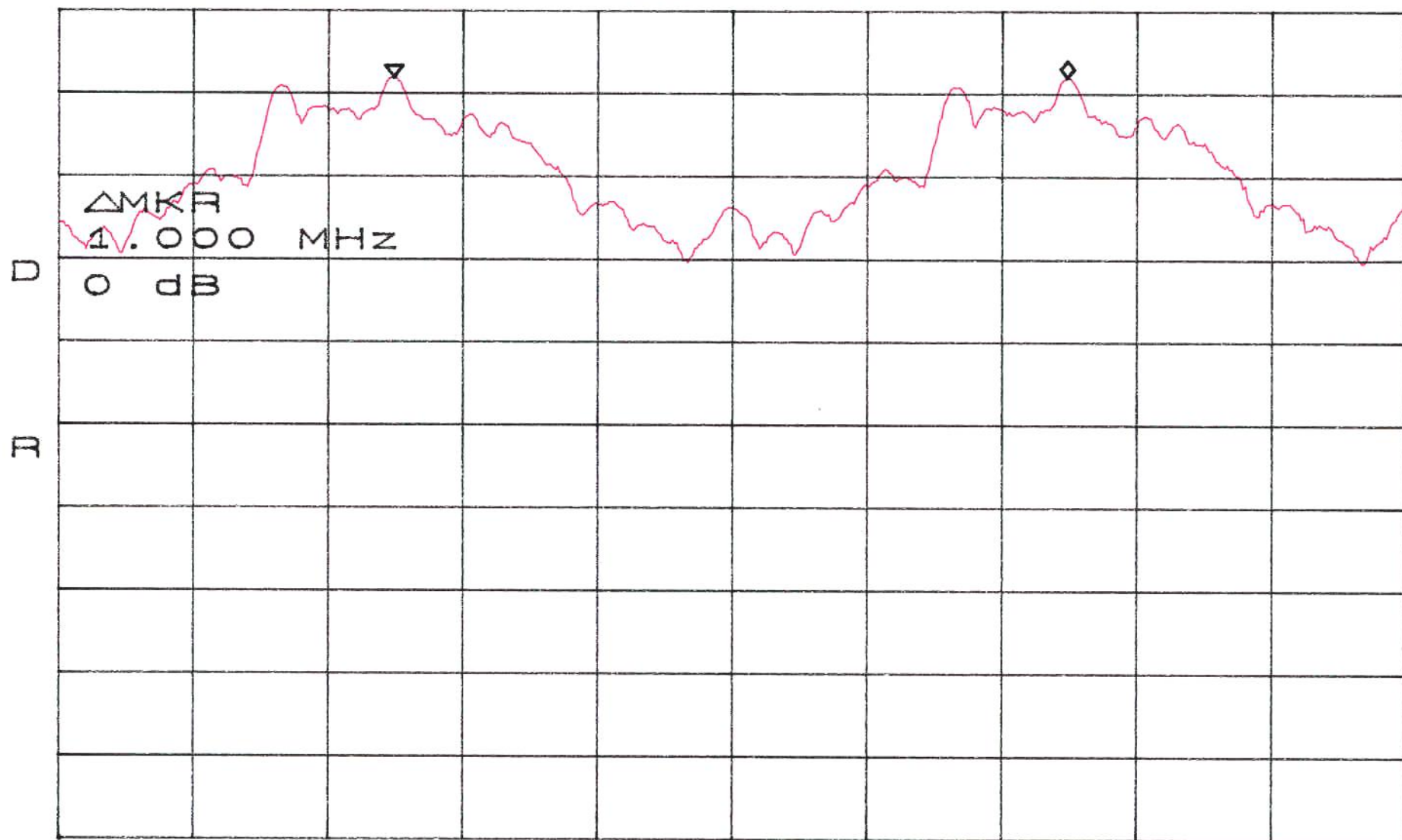
ATTEN 10dB

RL 21.0dBm

10dB/

Δ MKR 0dB

1.000MHz



CENTER 2.479500GHz

SPAN 2.000MHz

*RBW 30kHz

*VBW 100kHz

*SWP 500ms

Appendix 3 : Plotted Data for Total Used Hopping Frequencies

ATTEN 10dB

RL 21.0dBm

10dB/

D

μ

START 2.400000GHz

STOP 2.483500GHz

*RBW 100kHz

*VBW 1.0MHz

*SWP 500ms

Appendix 4 : Plotted Data for Channel Bandwidth

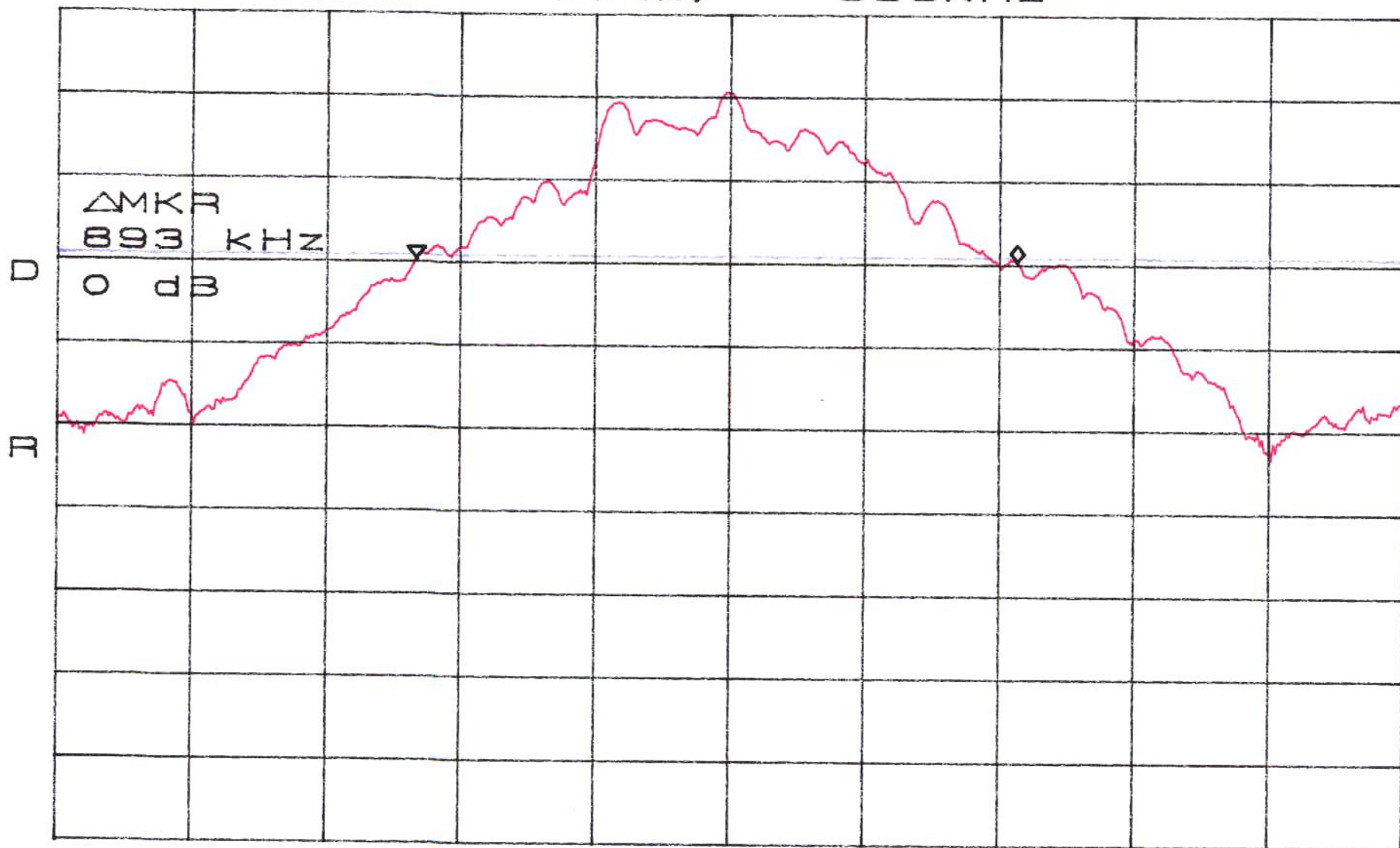
ATTEN 20dB

RL 22.0dBm

10dB/

Δ MKR 0dB

893KHz



CENTER 2.402000GHz

SPAN 2.000MHz

*RBW 30KHz

*VBW 1.0MHz

SWP 50.0ms